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DDR4 ECC SORDIMM VR9FRxx72x8xxx

The Viking DDR4 SORDIMM memory module offers lower operating voltages, higher module densities and faster speed categories than the prior DDR3 generation. JEDEC DDR4 (JESD79-4) has been defined to provide higher performance, with improved reliability and reduced power, thereby representing a significant achievement relative to previous DRAM memory technologies.

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REVISION HISTORY

Revision	Release Date	Description of Change	Checked By (Full Name)
X1	8/01/14	Preliminary release	
A	8/28/15	Initial release from modified/combined PS9FUxx72x8xxx_C (), PS9FRxx72x8xxx_X1 (pinout, mechanical outline,) PS9WRxx72x8xxx_A (block diagram)	
B	5/11/17	Revise logo and color scheme. Change company address	
C	7/28/17	Add DDR4-2666	
D	9/11/17	Add 32GB PNs. Add quad rank block diagram. Update DDR4 Timing Summary and Addressing table. Add DDR4-2666 speed bin and timing parameters .	
E	3/7/18	revise mechanical outline dwg per A002305A	

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All printed circuit boards (PCBs) have a flammability rating of UL94V-0.

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260 pin Ordering Information and Module Configuration

Viking Part Number	Voltage	Capacity	Module Configuration	Device Configuration	Device Package	Ranks	Speed	CAS Latency
VR9FR127228HBGyz	1.2V	4GB	512Mx72	512Mx8 (9)	4Gb FBGA	1	DDR4-14900	CL13 (13-13-13)
VR9FR127228HBHyz	1.2V	4GB	512Mx72	512Mx8 (9)	4Gb FBGA	1	DDR4-17000	CL15 (15-15-15)
VR9FR127228HBJyz	1.2V	4GB	512Mx72	512Mx8 (9)	4Gb FBGA	1	DDR4-19200	CL17 (17-17-17)
VR9FR127228HBKyz	1.2V	4GB	512Mx72	512Mx8 (9)	4Gb FBGA	1	DDR4-21300	CL19 (19-19-19)
VR9FR1G7228HBGyz	1.2V	8GB	1Gx72	512Mx8 (18)	4Gb FBGA	2	DDR4-14900	CL13 (13-13-13)
VR9FR1G7228HBHyz	1.2V	8GB	1Gx72	512Mx8 (18)	4Gb FBGA	2	DDR4-17000	CL15 (15-15-15)
VR9FR1G7228HBJyz	1.2V	8GB	1Gx72	512Mx8 (18)	4Gb FBGA	2	DDR4-19200	CL17 (17-17-17)
VR9FR1G7228HBKyz	1.2V	8GB	1Gx72	512Mx8 (18)	4Gb FBGA	2	DDR4-21300	CL19 (19-19-19)
VR9FR1G7228JBGyz	1.2V	8GB	1Gx72	1024Mx8 (9)	8Gb FBGA	1	DDR4-14900	CL13 (13-13-13)
VR9FR1G7228JBHyz	1.2V	8GB	1Gx72	1024Mx8 (9)	8Gb FBGA	1	DDR4-17000	CL15 (15-15-15)
VR9FR1G7228JBJyz	1.2V	8GB	1Gx72	1024Mx8 (9)	8Gb FBGA	1	DDR4-19200	CL17 (17-17-17)
VR9FR1G7228JBKyz	1.2V	8GB	1Gx72	1024Mx8 (9)	8Gb FBGA	1	DDR4-21300	CL19 (19-19-19)
VR9FR2G7228JBGyz	1.2V	16GB	2Gx72	1024Mx8 (18)	8Gb FBGA	2	DDR4-14900	CL13 (13-13-13)
VR9FR2G7228JBHyz	1.2V	16GB	2Gx72	1024Mx8 (18)	8Gb FBGA	2	DDR4-17000	CL15 (15-15-15)
VR9FR2G7228JBJyz	1.2V	16GB	2Gx72	1024Mx8 (18)	8Gb FBGA	2	DDR4-19200	CL17 (17-17-17)
VR9FR2G7228JBKyz	1.2V	16GB	2Gx72	1024Mx8 (18)	8Gb FBGA	2	DDR4-21300	CL19 (19-19-19)
VR9FR4G7228JEGyz	1.2V	32GB	4Gx72	(1024Mx8)*2 18 DDP, 36 die	16Gb DDP FBGA	4	DDR4-14900	CL13 (13-13-13)
VR9FR4G7228JEHyz	1.2V	32GB	4Gx72	(1024Mx8)*2 18 DDP, 36 die	16Gb DDP FBGA	4	DDR4-17000	CL15 (15-15-15)
VR9FR4G7228JEJyz	1.2V	32GB	4Gx72	(1024Mx8)*2 18 DDP, 36 die	16Gb DDP FBGA	4	DDR4-19200	CL17 (17-17-17)
VR9FR4G7228JEKyz	1.2V	32GB	4Gx72	(1024Mx8)*2 18 DDP, 36 die	16Gb DDP FBGA	4	DDR4-21300	CL19 (19-19-19)

Notes:

- For part numbers containing a lowercase x, contact Viking for the full PN.
- The lowercase letters y and z are wildcard characters that indicate DRAM vendor and die revisions and /or for customer specific locked BOMs. Refer to the Viking part number coversheet for details.

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Features

- JEDEC Standard Power Supply
 - VDD = VDDQ = 1.2V± 5% (1.14V-1.26V)
 - External VPP = 2.5 Volt +10%, -5%
 - VDDSPD = 2.2 to 2.8 Volts
- 260 pin Small Outline Dual-In-Line Memory Module
- Point-to-Point topology to reduce loading
- Pseudo-open drain (POD12) DQ lines
- Internally generated VrefDQ
- ECC recovery from command and parity errors
- On-chip CA Parity detection for the command/address bus
- Programmable CAS Latency: 13, 15, 17
- Programmable CAS Write Latency (CWL).
- Programmable Additive Latency (Posted CAS)
- Per DRAM addressability is supported
- Data Bus Inversion support for x8 devices
- Selectable Fixed burst chop (BC4) of 4 and burst length (BL8) of 8 on-the-fly (OTF) via the mode register set (MRS)
- 8n prefetch with 2 or 4 selectable bank groups: 16 banks (4 bank groups x 4 banks per bank group)
- Separate activation, read, write, refresh operations for each bank group
- 7 mode registers
- Dynamic On-Die-Termination (ODT) and ODT Park for improved signal integrity.
- Self Refresh and several Power Down Modes
- DLL-off mode for power savings
- System Level Timing Calibration Support via Write Leveling and Multi Purpose Register (MPR) Read Pattern
- Serial Presence Detect with EEPROM
- Two On-DIMM Thermal Sensors
- Asynchronous Reset
- Bidirectional Differentially Buffered Data Strobes(DQS)
- SORDIMM dimensions per JEDEC MO-310 maximum limits
- RoHS Compliant

DDR4 SPEED BIN Nomenclature

Module Standard	SDRAM Standard	Clock
DDR4-14900	DDR4-1866	933 MHz
DDR4-17000	DDR4-2133	1066 MHz
DDR4-19200 ¹	DDR4-2400	1200 MHz
DDR4-21300 ¹	DDR4-2667	1333 MHz
DDR4-25600 ¹	DDR4-3200	1600 MHz

Notes:

1. Contact Viking for availability date

DDR4 Timing Summary

MT/s	tCK (ns)	CAS Latency (tCK)	tRCD (ns)	tRP (ns)	tRAS (ns)	tRC (ns)	CL-tRCD-tRP
DDR4-1866	1.071	13	13.92	13.92	34	47.92	13-13-13
DDR4-2133	0.93	15	14.06	14.06	33	47.05	15-15-15
DDR4-2400	0.83	17	14.16	14.16	32	46.16	17-17-17
DDR4-2666	0.75	22	14.25	14.25	32	46.25	19-19-19

Notes:

- CL = CAS Latency, tRCD = Activate –to-Command Time, tRP = Precharge Time. Refer to Speed Bin tables for details.

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Addressing

		4GB(1Rx8) 512Mx8 DRAM	8GB(1Rx8) 1024Mx8 DRAM	16GB(2Rx8) 1024Mx8 DRAM	32GB(4Rx8) 1024Mx8 DRAM
Bank Address	# of Bank Groups	4	4	4	4
	BG Address	BG0~BG1	BG0~BG1	BG0~BG1	BG0~BG1
	Bank Address in a BG	BA0~BA1	BA0~BA1	BA0~BA1	BA0~BA1
Row Address		A0~A14	64K:A0~A15	64K:A0~A16	64K:A0~A16
Column Address		A0~ A9	A0~ A9	A0~ A9	A0~ A9
Page size		512B	512B	512B	512B
Refresh Count		4K	8K	8K	8K

Note:

- Micron datasheet specified 512B / 1KB as page size with "Die revision dependant".
- In Hynix and Samsung Datasheet specifies 512B for x4 Device.

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DDR4 260-pin SODIMM Pin Wiring Assignments/Configurations

Pin#	Symbol	Pin#	Symbol	Pin#	Symbol	Pin#	Symbol	Pin#	Symbol	Pin#	Symbol
1	VSS	45	DQ21	89	VSS	133	A1	177	DQS4_c	221	DQS6_t
2	VSS	46	DQ20	90	VSS	134	EVENT_n	178	DM4_n/DBI4_n	222	VSS
3	DQ5	47	VSS	91	CB1, NC	135	VDD	179	DQS4_t	223	VSS
4	DQ4	48	VSS	92	CB0, NC	136	VDD	180	VSS	224	DQ54
5	VSS	49	DQ17	93	VSS	137	CK0_t	181	VSS	225	DQ55
6	VSS	50	DQ16	94	VSS	138	CK1_t	182	DQ39	226	VSS
7	DQ1	51	VSS	95	DQS8_c	139	CK0_c	183	DQ38	227	VSS
8	DQ0	52	VSS	96	DBI8_n	140	CK1_c	184	VSS	228	DQ50
9	VSS	53	DQS2_c	97	DQS8_t	141	VDD	185	VSS	229	DQ51
10	VSS	54	DM2_n/DBI2_n	98	VSS	142	VDD	186	DQ35	230	VSS
11	DQS0_c	55	DQS2_t	99	VSS	143	PARITY	187	DQ34	231	VSS
12	DM0_n/DBI0_n	56	VSS	100	CB6, NC	144	A0	188	VSS	232	DQ60
13	DQS0_t	57	VSS	101	CB2, NC	145	BA1	189	VSS	233	DQ61
14	VSS	58	DQ22	102	VSS	146	A10_AP	190	DQ45	234	VSS
15	VSS	59	DQ23	103	VSS	147	VDD	191	DQ44	235	VSS
16	DQ6	60	VSS	104	CB7, NC	148	VDD	192	VSS	236	DQ57
17	DQ7	61	VSS	105	CB3, NC	149	CS0_n	193	VSS	237	DQ56
18	VSS	62	DQ18	106	VSS	150	BA0	194	DQ41	238	VSS
19	VSS	63	DQ19	107	VSS	151	WE_n/A14	195	DQ40	239	VSS
20	DQ2	64	VSS	108	RESET_n	152	RAS_n/A16	196	VSS	240	DQS7_c
21	DQ3	65	VSS	109	CKE0	153	VDD	197	VSS	241	DM6_n/DBI6_n
22	VSS	66	DQ28	110	CKE1	154	VDD	198	DQS5_c	242	DQS7_t
23	VSS	67	DQ29	111	VDD	155	ODT0	199	DM5_n/DBI5_n	243	VSS
24	DQ12	68	VSS	112	VDD	156	A15/CAS_n	200	DQS5_t	244	VSS
25	DQ13	69	VSS	113	BG1	157	CS1_n	201	VSS	245	DQ62
26	VSS	70	DQ24	114	ACT_n	158	A13	202	VSS	246	DQ63
27	VSS	71	DQ25	115	BG0	159	VDD	203	DQ46	247	VSS
28	DQ8	72	VSS	116	ALERT_n	160	VDD	204	DQ47	248	VSS
29	DQ9	73	VSS	117	VDD	161	ODT1	205	VSS	249	DQ58
30	VSS	74	DQS3_c	118	VDD	162	C0/CS2_n/NC	206	VSS	250	DQ59
31	VSS	75	DM3_n/DBI3_n	119	A12	163	VDD	207	DQ42	251	VSS
32	DQS1_c	76	DQS3_t	120	A11	164	VREFCA	208	DQ43	252	VSS
33	DM1_n/DBI1_n	77	VSS	121	A9	165	C1/CS3_n/NC	209	VSS	253	SCL
34	DQS1_t	78	VSS	122	A7	166	RFU	210	VSS	254	SDA
35	VSS	79	DQ30	123	VDD	167	VSS	211	DQ52	255	VDDSPD
36	VSS	80	DQ31	124	VDD	168	VSS	212	DQ53	256	SA0
37	DQ15	81	VSS	125	A8	169	DQ37	213	VSS	257	VPP
38	DQ14	82	VSS	126	A5	170	DQ36	214	VSS	258	VTT
39	VSS	83	DQ26	127	A6	171	VSS	215	DQ49	259	VPP
40	VSS	84	DQ27	128	A4	172	VSS	216	DQ48	260	SA1
41	DQ10	85	VSS	129	VDD	173	DQ33	217	VSS		
42	DQ11	86	VSS	130	VDD	174	DQ32	218	VSS		
43	VSS	87	CB5, NC	131	A3	175	VSS	219	DQS6_c		
44	VSS	88	CB4, NC	132	A2	176	VSS	220	DM7_n/DBI7_n		

Notes:

- VPP is 2.5V DC
- A15 needed for 4GBit DRAM, A16 needed for 8GBit DRAM, A17 needed for 16GBit DRAM
- Only x8 and x16 DRAM support Data Mask (DM) and Data Bus Inversion (DBI). Only x8 DRAM support TDQS
- DM & DBI functions are supported with dedicated one pin labeled as DM_n/DBI_n
- The pin is bi-directional pin for DRAM. The DM_n/DBI_n pin is Active Low as DDR4 supports VDDQ reference termination.
- DM & DBI functions are programmable through DRAM Mode Register (MR). The

MR bit location is bit A11 in MR1 and bit A12:A10 in MR5 . Write operation: Either DM or DBI function can be enabled but both functions cannot be enabled simultaneously. When both DM and DBI functions are disabled, DRAM turns off its input receiver and does not expect any valid logic level. Read operation: Only DBI function applies. When DBI function is disabled, DRAM turns off its output driver and does not drive any valid logic level. DM & DBI functions are described in more detail on x8 based datasheets

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PIN FUNCTION DESCRIPTION

Pin Name	Description	Pin Name	Description
A0-A17'	Register address input	SCL	I2C serial bus clock for SPD/TS and register
BA0, BA1	Register bank select input	SDA	I2C serial bus data line for SPD/TS and register
BG0, BG1	Register bank group select input	SA0-SA2	I2C slave address select for SPD/TS and register
RAS_n ²	Register row address strobe input	PAR	Register parity input
CAS_n ³	Register column address strobe input	VDD	SDRAM core power supply
WE_n ⁴	Register write enable input		
CS0_n, CS1_n, CS2_n, CS3_n	DIMM Rank Select Lines input		
CKE0, CKE1	Register clock enable lines input	VREFCA	SDRAM command/address reference supply
ODT0, ODT1	Register on-die termination control lines input	VSS	Power supply return (ground)
ACT_n	Register input for activate input	VDDSPD	Serial SPD/TS positive power supply
DQ0-DQ63	DIMM memory data bus	ALERT_n	Register ALERT_n output
CB0-CB7	DIMM ECC check bits	Vpp	DRAM Activation Power Supply
TDQS9_t-TDQS17_t	Data Buffer data strobes (positive line of differential pair)		
TDQS9_c- TDQS17_c	Data Buffer data strobes (negative line of differential pair)	RESET_n	Set Register and SDRAMs to a Known state
		EVENT_n	SPD signals a thermal event has occurred.
CK0_t, CK1_t	Register clock input (positive line of differential pair)	Vtt	SDRAM I/O termination supply
CK0_c, CK1_c	Register clocks input (negative line of differential pair)	RFU	Reserved for future use

Notes:

1. Address A17 is only valid for 16Gbit DRAM
2. RAS_n is a multiplexed function with A16. (A16 needed for 8Gbit DRAM)
3. CAS_n is a multiplexed function with A15. (A15 needed for 4Gbit DRAM)
4. WE_n is a multiplexed function with A14

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Input/Output Functional Descriptions

Symbol	Type	Function
CK_t, CK_c	Input	Clock: CK_t and CK_c are differential clock inputs. All address and control input signals are sampled on the crossing of the positive edge of CK_t and negative edge of CK_c.
CKE, (CKE1)	Input	Clock Enable: CKE HIGH activates, and CKE Low deactivates, internal clock signals and device input buffers and output drivers. Taking CKE Low provides Precharge Power-Down and Self-Refresh operation (all banks idle), or Active Power-Down (row Active in any bank). CKE is asynchronous for Self-Refresh exit. After VREFCA and VREFDQ have become stable during the power on and initialization sequence, they must be maintained during all operations (including Self-Refresh). CKE must be maintained high throughout read and write accesses. Input buffers, excluding CK, CK_c, ODT and CKE, are disabled during power-down. Input buffers, excluding CKE, are disabled during Self-Refresh.
CS_n, (CS1_n)	Input	Chip Select: All commands are masked when CS_n is registered HIGH. CS_n provides for external Rank selection on systems with multiple Ranks. CS_n is considered part of the command code.
C0,C1,C2	Input	Chip ID: Chip ID is only used for 3DS for 2,4,8high stack via TSV to select each slice of stacked component. Chip ID is considered part of the command code.
ODT, (ODT1)	Input	On Die Termination: ODT (registered HIGH) enables termination resistance internal to the DDR4 SDRAM. When enabled, ODT is only applied to each DQ, DQS_t, DQS_c and DM_n/DBI_n/TDQS_t,NU/TDQS_c (When TDQS is enabled via Mode Register A11=1 in MR1) signal for x8 configurations. For x16 configuration ODT is applied to each DQ, DQSU_c, DQSU_t, DQSL_t, DQSL_c, DMU_n, and DML_n signal. The ODT pin will be ignored if MR1 is programmed to disable RTT_NOM.
ACT_n	Input	Activation Command Input: ACT_n defines the Activation command being entered along with CS_n. The input into RAS_n/A16, CAS_n/A15 and WE_n/A14 will be considered as Row Address A16, A15 and A14.
RAS_n/A16, CAS_n/A15, WE_n/A14	Input	Command Inputs RAS_n/A16, CAS_n/A15 and WE_n/A14 (along with CS_n) define the command being entered. Those pins have multi function. For example, for activation with ACT_n Low, those are Addressing like A16,A15 and A14 but for non-activation command with ACT_n High, those are Command pins for Read, Write and other command defined in command truth table.
DM_n/DBI_n/ TDQS_t, (DMU_n/DBIU_n), (DML_n/DBIL_n)	Input/ Output	Input Data Mask and Data Bus Inversion: DM_n is an input mask signal for write data. Input data is masked when DM_n is sampled LOW coincident with that input data during a Write access. DM_n is sampled on both edges of DQS. DM is muxed with DBI function by Mode Register A10,A11,A12 setting in MR5. For x8 device, the function of DM or TDQS is enabled by Mode Register A11 setting in MR1. DBI_n is an input/output identifying whether to store/output the true or inverted data. If DBI_n is LOW, the data will be stored/output after inversion inside the DDR4 SDRAM and not inverted if DBI_n is HIGH. TDQS is only supported in x8.
BG0 - BG1	Input	Bank Group Inputs: BG0 - BG1 define to which bank group an Active, Read, Write or Precharge command is being applied. BG0 also determines which mode register is to be accessed during a MRS cycle. x4/8 have BG0 and BG1 but x16 has only BG0.

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Input/Output Functional Descriptions (cont.)

Symbol	Type	Function
BA0 - BA1	Input	Bank Address Inputs: BA0 - BA1 define to which bank an Active, Read, Write or Precharge command is being applied. Bank address also determines if the mode register or extended mode register is to be accessed during a MRS cycle.
A0 - A17	Input	Address Inputs: Provided the row address for ACTIVATE Commands and the column address for Read/Write commands to select one location out of the memory array in the respective bank. (A10/AP, A12/BC_n, RAS_n/A16, CAS_n/A15 and WE_n/A14 have additional functions, see other rows. The address inputs also provide the op-code during Mode Register Set commands.
A10 / AP	Input	Auto-precharge: A10 is sampled during Read/Write commands to determine whether Autoprecharge should be performed to the accessed bank after the Read/Write operation. (HIGH: Autoprecharge; LOW: no Autoprecharge). A10 is sampled during a Precharge command to determine whether the Precharge applies to one bank (A10 LOW) or all banks (A10 HIGH). If only one bank is to be precharged, the bank is selected by bank addresses.
A12 / BC_n	Input	Burst Chop: A12 / BC_n is sampled during Read and Write commands to determine if burst chop (on-the-fly) will be performed. (HIGH, no burst chop; LOW: burst chopped). See command truth table for details.
RESET_n	Input	Active Low Asynchronous Reset: Reset is active when RESET_n is LOW, and inactive when RESET_n is HIGH. RESET_n must be HIGH during normal operation. RESET_n is a CMOS rail to rail signal with DC high and low at 80% and 20% of VDD.
DQ	Input / Output	Data Input/ Output: Bi-directional data bus. If CRC is enabled via Mode register then CRC code is added at the end of Data Burst. Any DQ from DQ0~DQ3 may indicate the internal Vref level during test via Mode Register Setting MR4 A4=High. Refer to vendor specific datasheets to determine which DQ is used.
CB	Input / Output	Check Bit Input/ Output: Bi-directional ECC portion of data bus for x72 configurations
DQS_t, DQS_c, DQSU_t, DQSU_c, DQSL_t, DQSL_c	Input / Output	Data Strobe: output with read data, input with write data. Edge-aligned with read data, centered in write data. For x16, DQSL corresponds to the data on DQL0-DQL7; DQSU corresponds to the data on DQU0-DQU7. The data strobe DQS_t, DQSL_t, and DQSU_t are paired with differential signals DQS_c, DQSL_c, and DQSU_c, respectively, to provide differential pair signaling to the system during reads and writes. DDR4 SDRAM supports differential data strobe only and does not support single-ended.

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Input/Output Functional Descriptions (cont.)

Symbol	Type	Function
ALERT_n	Output	Alert: It has multi functions such as CRC error flag, Command and Address Parity error flag. If there is error in CRC, then Alert_n goes LOW for the period time interval and goes back HIGH. IF there is error in Command Address Parity Check, then Alert_n goes LOW for relatively long period until on going DRAM internal recovery transaction to complete.
TEN	Input	Boundary Scan Mode Enable: Required on x16 devices and optional input on x4/x8 with densities equal to or greater than 8Gb. HIGH in this pin will enable boundary scan operation along with other pins. It is a CMOS rail to rail signal with DC high and low at 80% and 20% of VDD.
NC		No Connect: No internal electrical connection is present.
VDDQ	Supply	DQ Power Supply: 1.2 V +/- 0.06 V
VSSQ	Supply	DQ Ground
VDD	Supply	Power Supply: 1.2 V +/- 0.06 V
VSS	Supply	Ground
Vpp	Supply	DRAM Activation Power Supply: 2.5V (2.375V min , 2.75 max)
VREFCA	Supply	Reference voltage for CA
ZQ	Supply	Reference Pin for ZQ calibration

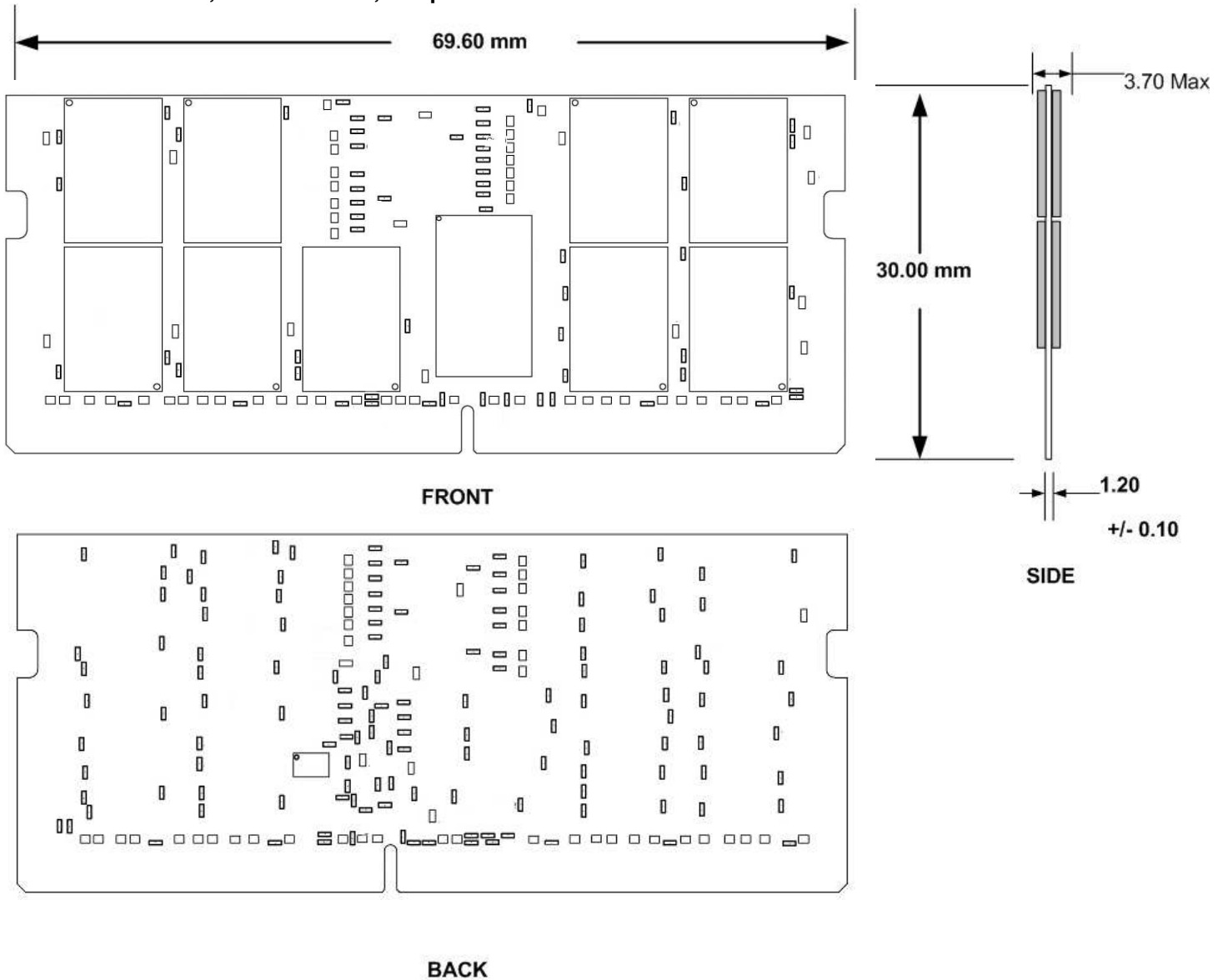
Note:

The input only pins (BG0-BG-1, BA0-BA1, A0-A17, ACT_n, RAS_n/A16, CAS_n/A15, WE_n/A14, CS_n, CKE, ODT, and RESET_n) do not supply termination.

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MECHANICAL OUTLINE

PHYSICAL LAYOUT, SINGLE RANK, 260 pin

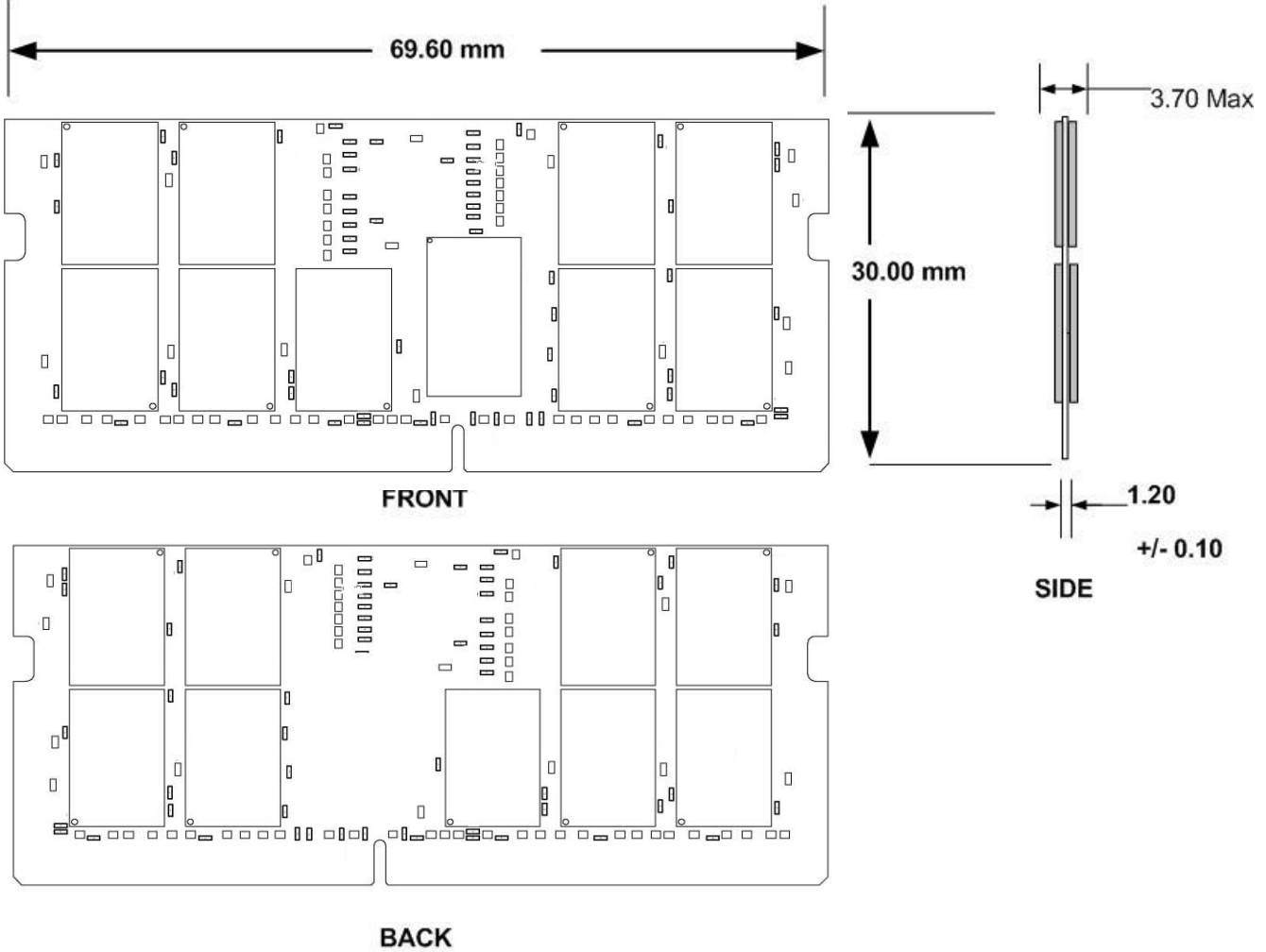


Notes:

- All dimensions in mm (inches)
- Tolerance is +/- 0.0127, unless otherwise stated
- Refer to JEDEC Standard Mechanical Outline MO-310 for other details

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PHYSICAL LAYOUT, DUAL RANK, 260 pin



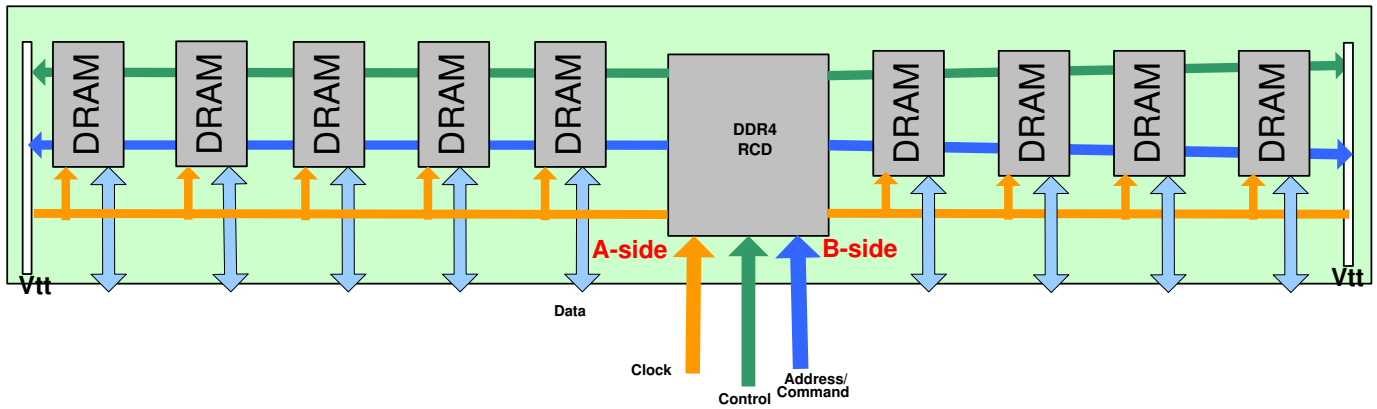
Notes:

- All dimensions in mm (inches)
- Tolerance is +/- 0.0127, unless otherwise stated
- Refer to JEDEC Standard Mechanical Outline MO-310 for other details

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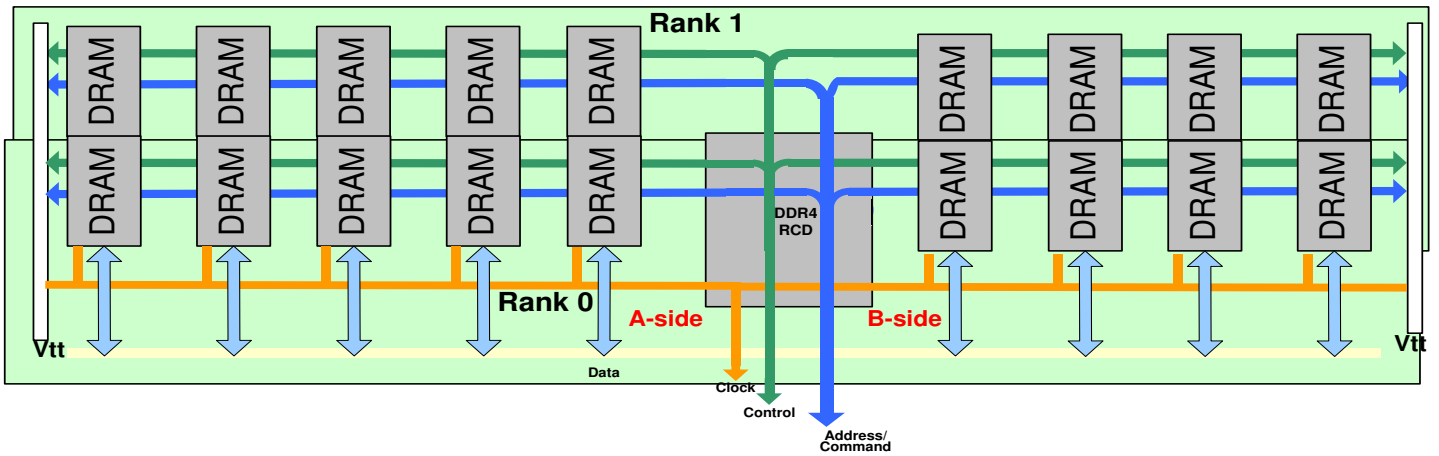
FUNCTIONAL BLOCK DIAGRAM

BLOCK DIAGRAM, SINGLE RANK



DDR4 HOST MEMORY INTERFACE

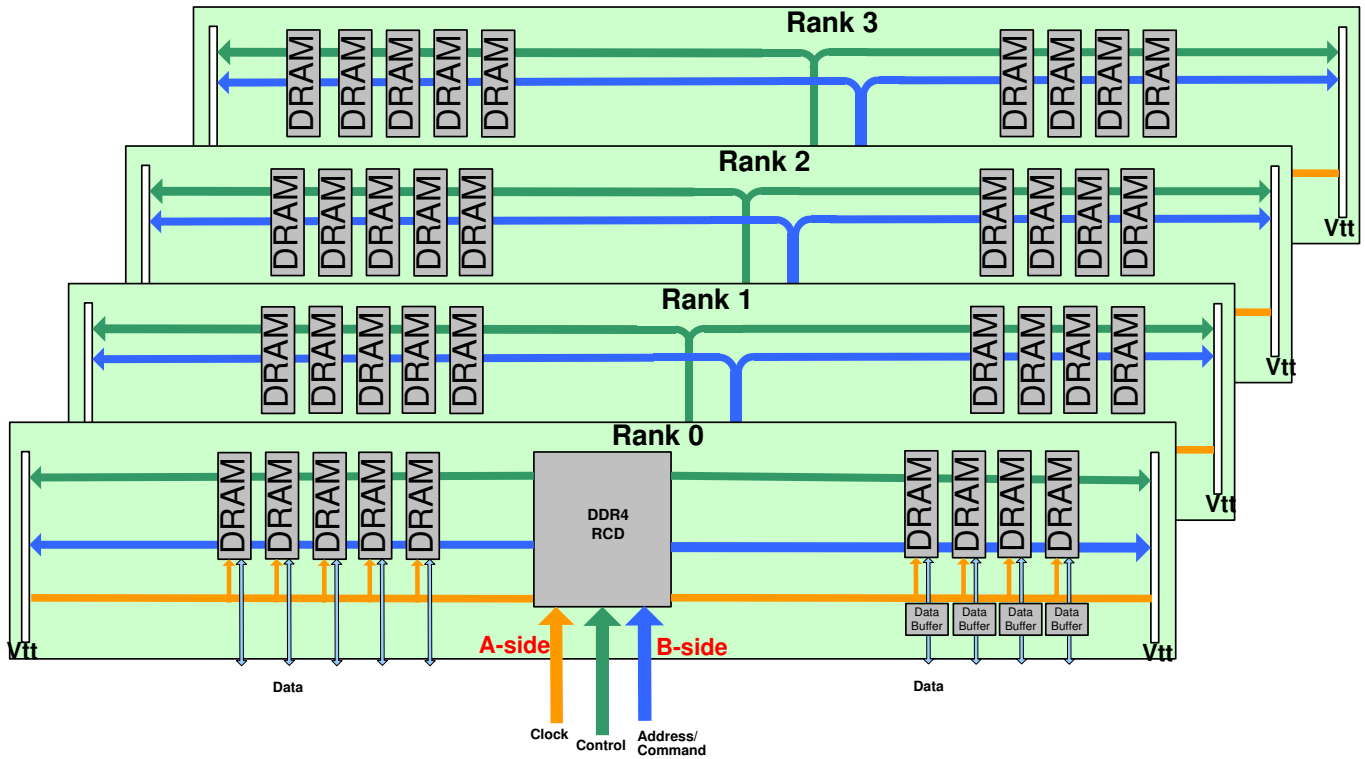
BLOCK DIAGRAM, DUAL RANK



DDR4 HOST MEMORY INTERFACE

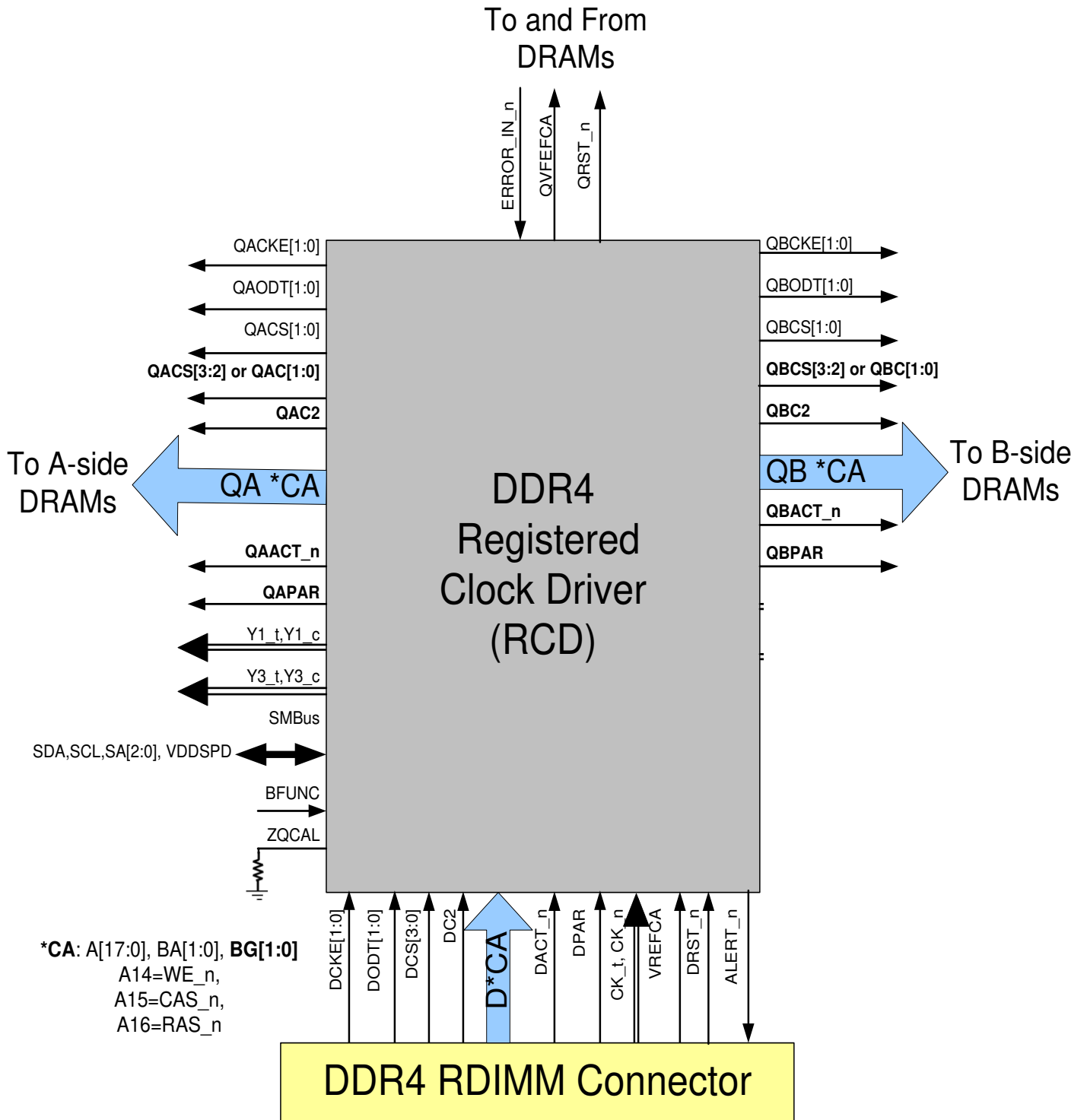
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FUNCTIONAL BLOCK DIAGRAM QUAD RANK

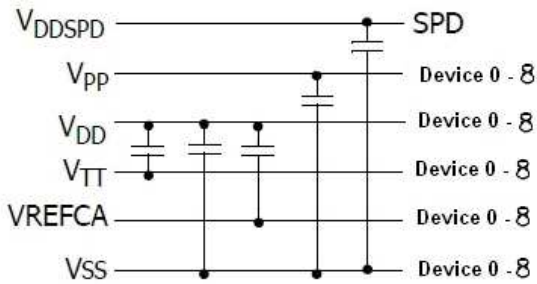


DDR4 HOST MEMORY INTERFACE

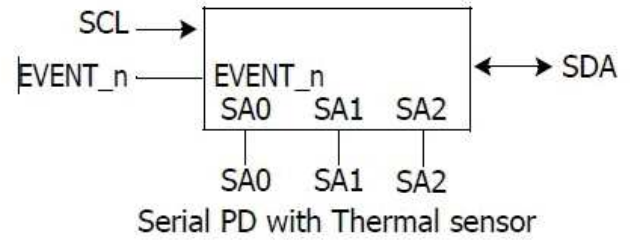
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(Device 0 - 8, for 1 ranks)



SPD and THERMAL SENSOR

Notes:

- Unless otherwise noted, resistor values are 15 Ω ±5%.
- See the Net Structure diagrams for all resistors associated with the command, address and control bus.
- ZQ resistors are 240 Ω ±1%. For all other resistor values, refer to the appropriate wiring diagram.
- Refer to EE1004-v and TSE2004av specifications for details.

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DQ Internal Vref Specifications

Parameter	Symbol	Min	Typ	Max	Unit	NOTE
Vref Max operating point Range 1	Vref_max_R1	-	-	92%	VDDQ	1, 11
Vref Min operating point Range 1	Vref_min_R1	60%	-	-	VDDQ	1,11
Vref Max operating point Range 2	Vref_max_R2	-	-	77%	VDDQ	1, 11
Vref Min operating point Range 2	Vref_min_R2	45%	-	-	VDDQ	1,11
Vref Stepsize	Vref_step	0.50%	0.65%	0.80%	VDDQ	2
Vref Set Tolerance	Vref_set_tol	-1.625%	0.00%	1.63%	VDDQ	3,4,6
		-0.15%	0.00%	0.15%	VDDQ	3,5,7
Vref Step Time	Vref_time-long	-	-	150	ns	9
	Vref_time-Short	-	-	60	ns	8
Vref Valid tolerance	Vref_val_tol	-0.15%	0.00%	0.15%	VDDQ	10

Notes:

- JESD8-24 specifies Vref to be 70% of VDDQ. Vref DC voltage referenced to VDDQ_DC. VDDQ_DC is 1.2V
- Vref stepsize increment/decrement range. Vref at DC level.
- $Vref_new = Vref_old + n * Vref_step$; n=number of step; if increment use "+"; if decrement use "-"
- The minimum value of Vref setting tolerance= $Vref_new - 1.625% * VDDQ$.
The maximum value of Vref setting tolerance= $Vref_new + 1.625% * VDDQ$. For n>4
- The maximum value of Vref setting tolerance= $Vref_new - 0.15% * VDDQ$.
The maximum value of Vref setting tolerance= $Vref_new + 0.15% * VDDQ$. For n&4 tbd
- Measured by recording the min and max values of the Vref output over the range, drawing a straight line between those points and comparing all other Vref output settings to that line
- Measured by recording the min and max values of the Vref output across 4 consecutive steps(n=4), drawing a straight line between those points and comparing all other Vref output settings to that line
- Time from MRS command to increment of decrement one step size for Vref
- Time from MRS command to increment of decrement more than one step size up to full range of Vref
- Only applicable for DRAM component level test/characterization purpose.
Not applicable for normal mode of operation. Vref valid is to qualify the step times which will be characterized at the component level.
- DRAM range1 or 2 set by MRS bit MR6,A6.

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OVERVIEW OF DDR4 SORDIMM MODULE OPERATION

The DDR4 architecture is generally a point-to-point topology with a dedicated channel design. The highest system performance levels can be achieved with DDR4-2133 and beyond, when the system is configured as 1 SORDIMM Per Channel (1DPC). DDR4 has more features than DDR3 with a pseudo-open drain (POD12) 1.2v I/O for the data channel, trained Vref, bank groups and write CRC. The POD12 interface only applies to the data channel. The address command channel behave like DDR3 using mid-point termination and mid-point Vref. The new bank group interleaving feature in DDR4 maximizes data transfer bandwidth.

DDR4 DRAM use pseudo-open drain (POD12) 1.2v drivers with Vdd terminations on DQ lines to increase data rates; unlike DDR3 DRAM that uses stub-series terminated logic drivers, The DRAM addressing scheme in DDR4 is organized into bank groups, Side A and Side B. The host DDR4 memory controller interleaves (multiplexes) among the bank groups to achieve high data rates. DDR4 architecture is a 8n prefetch with bank groups, including the use of two or four selectable bank groups. This will permit the DDR4 memory devices to have separate activation, read, write or refresh operations simultaneously underway in each of the unique bank groups to improve overall memory efficiency and bandwidth, especially when small memory granularities are used.

The data written to the SORDIMM is read back the same way. However when writing to the internal registers with a "load mode" operation, a specific address is required. This requires the controller to know if the rank is mirrored or not. There is a bit assignment in the SPD that indicates whether the module has been designed with a mirrored feature or not.

DDR4 offers ECC recovery from command and parity errors to prevent the host system from crashing. The use of CRC parity is an optional feature on address command and data; (Error command blocking when parity enabled and post CA parity. If the SORDIMM does not support CRC, the values of 0x00 will fill the CRC table. The new CA parity feature on the command/address bus provides a low-cost method of verifying the integrity of command and address transfers over a link, for all operations.

Some of the main attributes of DDR4 memory are:

- 1) Internally generated VrefDQ and Calibration.
VrefDQ is supplied by the DRAM internally.
VrefCA is supplied by the board.
- 2) The ACT_n activate pin replaces RAS#, CAS#, and WE# commands,
- 3) Alert_n for error checking
- 4) Bank group Interleaving
- 5) Improved training modes upon power-up
- 5) Nominal and dynamic ODT: Improvements to the ODT protocol and a new Park Mode allow for a nominal termination and dynamic write termination without having to drive the ODT pin
- 6) DQ bus gear-down mode for 2667 Mhz data rates and beyond
- 7) External VPP at 2.5V (for wordline boost)
- 8) 1.2V VDD power with power-saving features that include MPSM Maximum Power Savings Mode, Low Power Auto Self Refresh, Temperature Controlled Refresh, Fine Granularity Refresh, and CMD/ADDT latency. DLL off mode.

Important Note:

Longer boot-up times may be experienced in certain situations due to controller initiated functions such as VrefDQ calibration, write leveling and other trainings for the SORDIMM.

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DDR4 MODE REGISTERS

	A12	A11	A10	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0
MR0	RFU	Write Recovery and RTP			DLL Reset	Test Mode	CAS Latency CL			Burst Type	CL	Burst Length BL	
MR1	Qoff	TDQS	Rtt_NOM			Write Leveling	RFU	RFU	Additive Latency		Ron		DLL Enable
MR2	Write CRC	RFU	Rtt_WR		RFU	Auto Self Refresh		CWL			RFU	RFU	RFU
MR3	MPR Read Format		Write CMD Latency with CRC and DM		Fine Granularity Refresh			Temp Sensor	Per-DRAM Addr Mode	Gear down	MPR Enable	MPR Page	
MR4	Write Preamble	Read Preamble	Read Preamble Training Enable	Self Refresh Abort Enable	CS-to-Address Latency CAL			RFU	VrefDQ Monitor Enable	Temp Refresh Mode	Temp. Refresh Range	Max Power Down Enable	RFU
MR5	Read DBI Enable	Write DBI Enable	Data Mask Enable	Parity Persistent Error	Rtt_PARK			ODT input in Power Down	Panty Error Status	CRC Error Clear	CMD Address Parity Latency		
MR6	tCCD_L and tDLLK Timing			RFU	RFU	VrefDQ Training enable	VrefDQ Training Range	VretDQ Training Value					
MR7	Manufacturing use only to program the RCD												

Notes:

- Refer to JEDEC documentation for detail of the control/status bits

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DC OPERATING CONDITIONS AND CHARACTERISTICS

ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	Notes
Voltage on any pin relative to GND	Vin, Vout	-0.3 ~ 1.5	V	1,
Voltage on VDD supply relative to GND	VDD	-0.3 ~ 1.5	V	1,3
Voltage on VDDQ supply relative to GND	VDDQ	-0.3 ~ 1.5	V	1,3
Voltage on VPP supply relative to GND	VPP	-0.3 ~ 3.0	V	4
Module operating temperature (ambient)	T _{opr}	0 ~ 55	°C	1,5
Storage temperature	T _{stg}	-55 ~ +100	°C	1,2

Notes:

- Permanent device damage may occur if 'ABSOLUTE MAXIMUM RATINGS' are exceeded. Functional operation should be restricted to recommended operating condition.
Exposure to higher than recommended voltage for extended periods of time could affect device reliability. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability
- Storage Temperature is the case surface temperature on the center/top side of the DRAM. For the measurement conditions, please refer to JESD51- 2 standard.
- VDD and VDDQ must be within 300 mV of each other at all times and VREFCA must be not greater than 0.6 x VDDQ, When VDD and VDDQ are less than 500 mV; VREF may be equal to or less than 300 mV
- VPP must be equal or greater than VDD/VDDQ at all times
- Refer to JEDEC JC451 specification

DRAM Component Operating Temperature Range

Symbol	Parameter	Rating	Units	Note
T _{oper}	Normal Operating Temperature Range	0 to 85	°C	1,2
	Extended Temperature Range	85 to 95	°C	1,3

Notes:

- Operating Temperature TOPER is the case surface temperature on the center / top side of the DRAM. For measurement conditions, please refer to the JEDEC document JE51-2.
- The Normal Temperature Range specifies the temperatures where all DRAM specifications will be supported. During operation, the DRAM case temperature must be maintained between 0 - 85oC under all operating conditions.
- Some applications require operation of the DRAM in the Extended Temperature Range between 85oC and 95oC case temperature. Full specifications are guaranteed in this range, but the following additional conditions apply:
 - Refresh commands must be doubled in frequency, therefore reducing the Refresh interval tREFI to 3.9 μs. It is also possible to specify a component with 1X refresh (tREFI to 7.8μs) in the Extended Temperature Range. Please refer to the DIMM SPD for option availability.
 - If Self-Refresh operation is required in the Extended Temperature Range, then it is mandatory to either use the Manual Self-Refresh mode with Extended Temperature Range capability (MR2 A6 = 0b and MR2 A7 = 1b) or enable the optional Auto Self-Refresh mode (MR2 A6 = 1b and MR2 A7 = 0b). DDR4 SDRAMs support Auto Self-Refresh and in Extended Temperature Range and please refer to component datasheet and/or the DIMM SPD for tREFI requirements in the Extended Temperature Range

tREFI by Device Density

Parameter	Symbol	2Gb	4Gb	8Gb	16Gb	Units	
Average periodic refresh interval	tREFI	0°C ≤ T _{case} ≤ 85°C	7.8	7.8	7.8	7.8	μs
		85°C ≤ T _{case} ≤ 95°C	3.9	3.9	3.9	3.9	μs

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AC & DC Operating Conditions

DC OPERATING CONDITIONS AND CHARACTERISTICS (POD12)

Symbol	Parameter	Rating			Units	Notes
		Min	Typ	Max		
VDD	Supply Voltage VDD: PC4:1.2V±5%,	1.14	1.2	1.26	v	1,2,3
VDDQ	Supply Voltage for Output. Values in () are at 70% of VDD	1.14 (0.798)	1.2 (0.84)	1.26 (0.882)	v	1
VPP	2.5V +10%, -5%	2.375	2.5	2.75	v	3
VDDSPD	@2.5V	2.2	2.5	2.8	v	

Notes:

1. JESD8-24 specifies Vref to be 70% of VDDQ. Under all conditions VDDQ must be less than or equal to VDD.
2. VDDQ tracks with VDD. AC parameters are measured with VDD and VDDQ tied together.
3. DC bandwidth is limited to 20MHz.,
4. POD12 1.2 V Pseudo Open Drain Interface has a VDDQ value of 1.2V but the reference voltage allows POD12 to be used with other VDDQ values. POD12 signals have pull-up-only parallel input termination and have an asymmetric output drive impedance. For example, if the output drivers were using a 60 ohm pull-up drive impedance then the pull-down drivers would be expected to produce a 40 ohm pull-down drive impedance. POD12 does not explicitly call for series termination resistors, so it is suitable for point-to-point as well as multi-drop stub environments which may require some additional termination.

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DC CHARACTERISTICS, IDD CURRENTS

IDD DEFINITIONS

Symbol	Parameter
IDD0	One bank ACTIVATE-PRECHARGE current
IPP0	One bank ACTIVATE-PRECHARGE, Word Line Boost, IPP current
IDD1	One bank ACTIVATE-READ-PRECHARGE current
IDD2N	Precharge standby current
IDD2NT	Precharge standby ODT current
IDD2P	Precharge power-down current
IDD2Q	Precharge quiet standby current
IDD3N	Active standby current
IPP3N	Active standby IPP current
IDD3P	Active power-down current
IDD4R	Burst read current
IDDQ4R	Burst read IDDQ current
IDD4W	Burst write current
IDD5B	Burst refresh current (1x REF)
IPP5B	Burst refresh IPP current (1 x REF)
IDD6N	Self refresh current: Normal temperature range (0°C to +85°C)
IDD6E	Self refresh current: Extended temperature range (0°C to +95°C)
IDD6R	Self refresh current: Reduced temperature range (0°C to +45°C)
IDD6A	Auto self refresh current (25°C)
IDD6A	Auto self refresh current (45°C)
IDD6A	Auto self refresh current (75°C)
IDD7	Bank interleave read current
IPP7	Bank interleave read IPP current
IDD8	Maximum power-down current

Notes:

- 1) DDR4 IDD and IDDQ specs include the same DDR3 IDD and IDDQ specs with these exceptions:
 - a. IDD2P0 and IDD2P1 are replaced with a single IDD2P. There's no longer any difference in power for the DLL because of better DLL power management inside the DRAM device without any benefit for using slow exit.
 - b. IDD6 is renamed IDD6N Self Refresh Current: Normal Temperature Range
 - c. IDD6ET is renamed IDD6E Self-Refresh Current: Extended Temperature Range
 - d. IDD6TC is renamed IDD6AAut0 Self-Refresh Current
 - e. IDD8 is redefined from (optional) RESET Low Current to IDD8 Maximum Power Down Current, TBD
- 2) IDD values are an average (not peak) current drawn throughout the entire time that it takes to execute the set of conditions specified by JEDEC standards.
- 3) Consult with Viking for tools to help specify the Total Design Power (TDP)

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I_{DD6} Specification

Symbol	Temperature Range	Value	Unit	Notes
IDD6N	0 - 85 °C	22	mA	3,4
IDD6E	0 - 95 °C	33	mA	4,5,6
IDD6R	0 - 45°C	10	mA	4,6,9
IDD6A	0 °C ~ Ta	9	mA	4,6,7,8
	Tb ~ Ty	10	mA	4,6,7,8
	Tz ~ TOPERmax	16	mA	4,6,7,8

Notes:

1. Some IDD currents are higher for x16 organization due to larger page-size architecture.
2. Max. values for IDD currents considering worst case conditions of process, temperature and voltage.
3. Applicable for MR2 settings A6=0 and A7=0.
4. Supplier data sheets include a max value for IDD6.
5. Applicable for MR2 settings A6=0 and A7=1. IDD6ET is only specified for devices which support the Extended Temperature Range feature.
6. Refer to the supplier data sheet for the value specification method (e.g. max, typical) for IDD6ET and IDD6TC
7. Applicable for MR2 settings A6=1 and A7=0. IDD6TC is only specified for devices which support the Auto Self Refresh feature.
8. The number of discrete temperature ranges supported and the associated Ta - Tz values are supplier/design specific. Temperature ranges are specified for all supported values of TOPER. Refer to supplier data sheet for more information.
9. Applicable for MR2 settings TBD. IDD6R is verified by design and characterization, and may not be subject to production test.

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IDD CURRENTS, SINGLE RANK, 4Gbit

Symbol	DDR4-1866	DDR4-2133	DDR4-2400	Units
IDD0	522	540	576	mA
IPP0	36	36	36	mA
IDD1	567	585	612	mA
IDD2N	396	414	450	mA
IDD2NT	450	486	522	mA
IDD2P	270	270	288	mA
IDD2Q	351	351	369	mA
IDD3N	549	567	603	mA
IPP3N	27	27	27	mA
IDD3P	396	396	396	mA
IDD4R	1260	1350	1440	mA
IDDQ4R	288	324	360	mA
IDD4W	1404	1584	1764	mA
IDD5B	1710	1710	1728	mA
IPP5B	198	198	198	mA
IDD6N	180	180	180	mA
IDD6E	243	243	243	mA
IDD6R	90	90	90	mA
IDD6A (25°C)	81	81	81	mA
IDD6A (45°C)	90	90	90	mA
IDD6A (75°C)	144	144	144	mA
IDD7	1440	1665	1890	mA
IPP7	90	108	126	mA
IDD8	162	162	162	mA

Notes:

1. Users should refer to the DRAM supplier data sheet and/or the DIMM SPD to determine if DDR4 SDRAM devices support the following options or requirements referred to in this material.
2. Values as per Micron Datasheet Revision "A".